

Lab3 SMD Components

EERF – 6396

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1. Introduction

Objectives:

- a. Characterize the properties of SMD components
- b. Model the microstrip RF circuits in the form of lumped elements

Apparatus:

- a. Agilent E5071C Network Analyzer (100KHz \rightarrow 8.5GHz)
- b. Calibration Kit
- c. SMD component test board
- d. 100 Ω 0603 package resistor
- e. 47 pF 0603 package capacitor

2. Pre-Lab Discussion

- 1) The basics of VNA working have been studied
- 2) SOLT method of VNA calibration and have been studied
- 3) Basics of soldering were refreshed

3. Procedure

- **2 – port Calibration of VNA**

1. Press 'CAL' button on VNA
2. Select 2 Port Calibration
3. Follow the Short, Open, Load and Through for 2 port calibration
4. The R.L is measured to be 70 dB after calibration

- **Soldering the SMA connectors to the test board**

1. The test boards with $w = 3$ mm and $b = 1$ mm were tested for continuity
2. Solder the SMA connectors with sufficient spacing between them

- **S-parameters for 50-ohm “through” line**

1. Connect the 2 ports of the VNA across the 50 Ω through line
2. Measure and record S-parameters for 50-ohm “through” line

- **Perform auto-port extension for the 2 open lines**

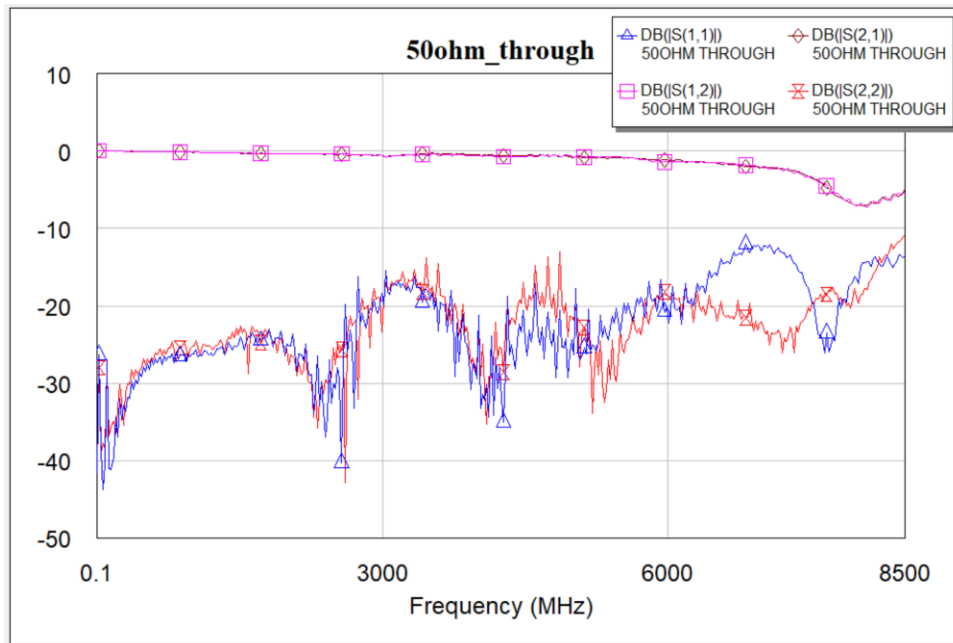
1. Connect the VNA across the middle open line
2. Set frequency sweep from 100 kHz to 4 GHz
3. Measure the S-parameters, time delay and electrical length
4. Repeat the procedure for the bottom line

- **Measure the response of Capacitor and Resistor**

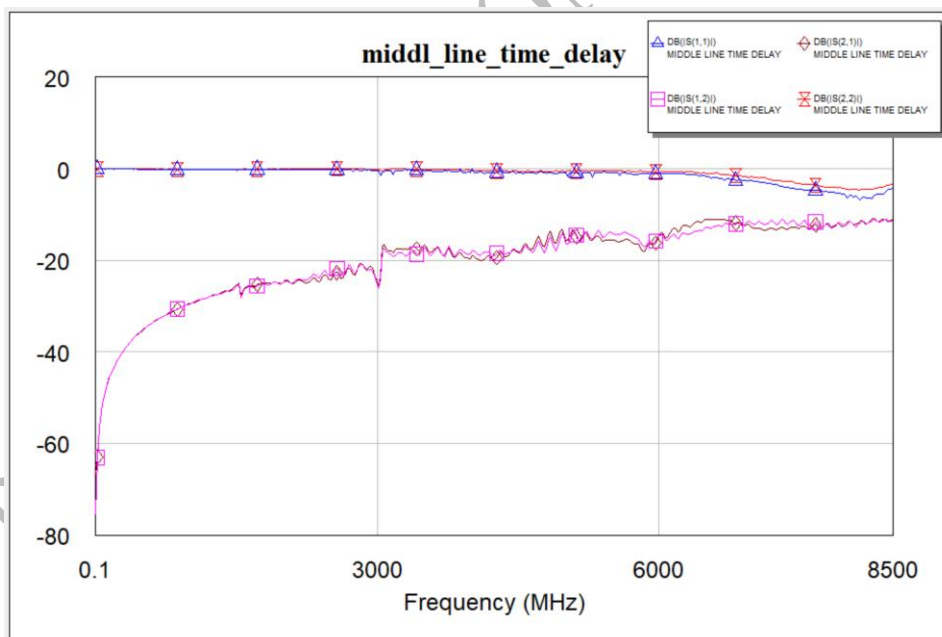
1. Solder the capacitor and measure the S-parameters once with auto port extension ON and once with auto port extension OFF
2. Solder the resistor on the bottom line and measure the S-parameters once with auto port extension ON and once with auto port extension OFF

4. Plots and Measurements

- S-parameters for 50-ohm “through” line



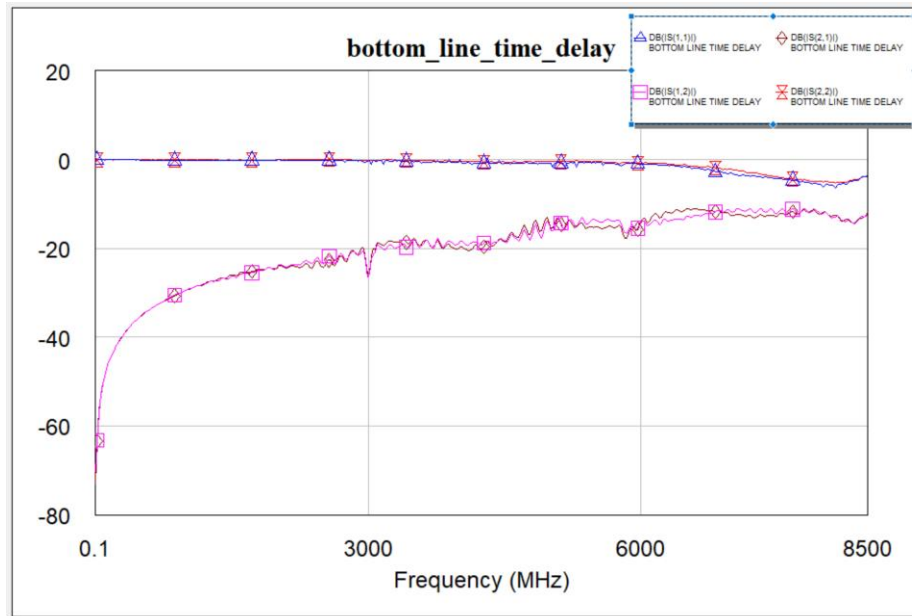
- S-parameters of middle open-circuit 50-ohm lines (without SMD component installed)



Time Delay for middle right Tx line: 166.38 ps \rightarrow 49.879mm

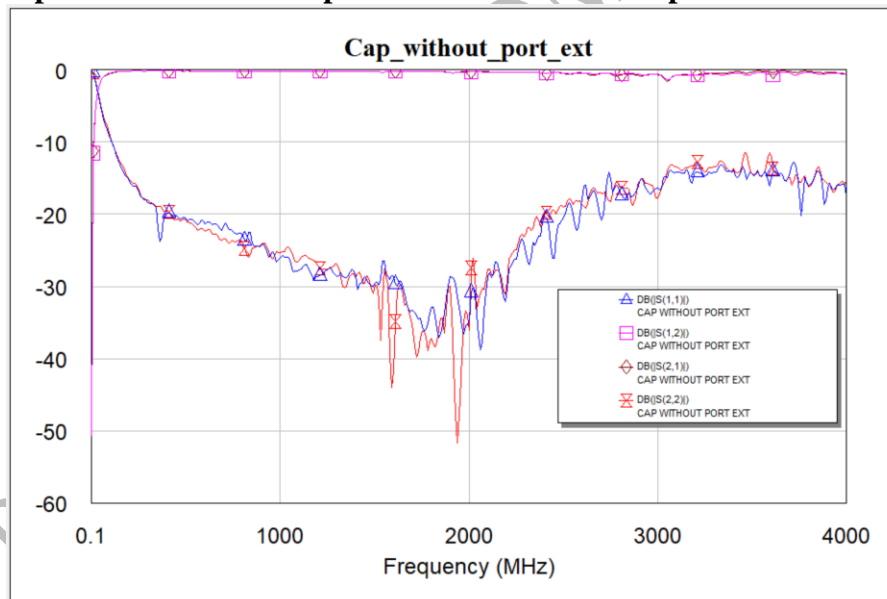
Time Delay for middle left Tx line: 160.15 ps \rightarrow 48.012mm

- S-parameters of bottom open-circuit 50-ohm lines (without SMD component installed)

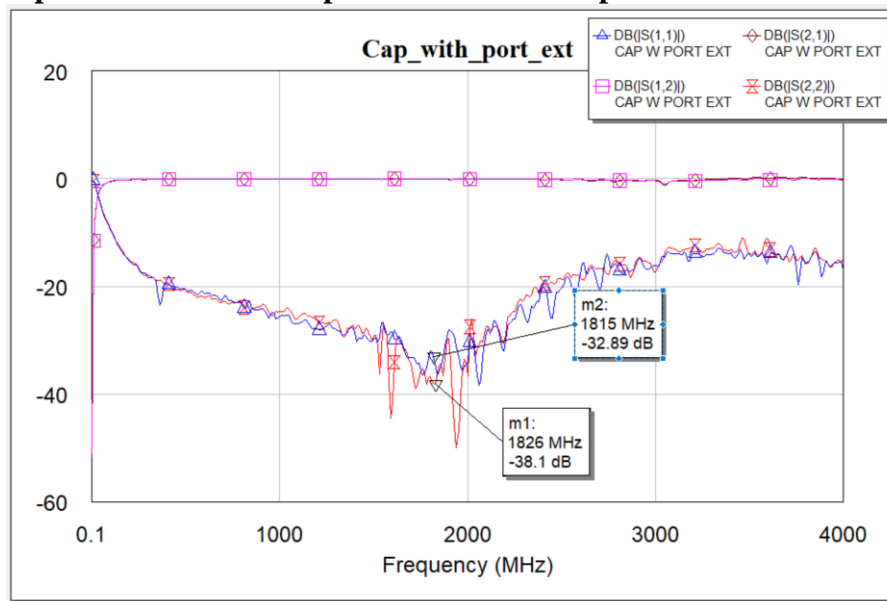


Time Delay for bottom right Tx line: 166.62 ps \rightarrow 49.951mm
 Time Delay for bottom left Tx line: 161.00 ps \rightarrow 48.267mm

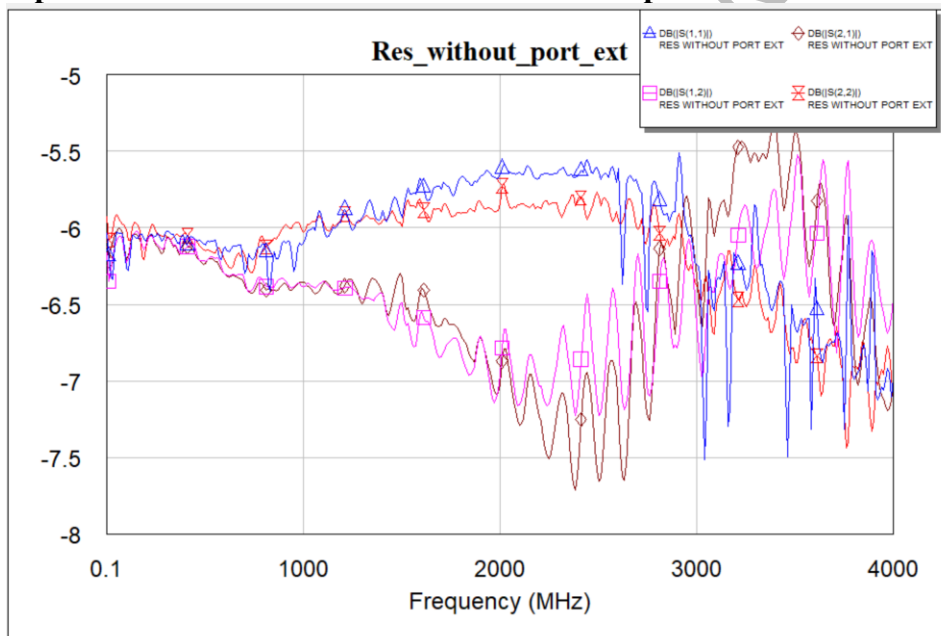
- S-parameters of the Capacitor **WITHOUT** auto-port extension



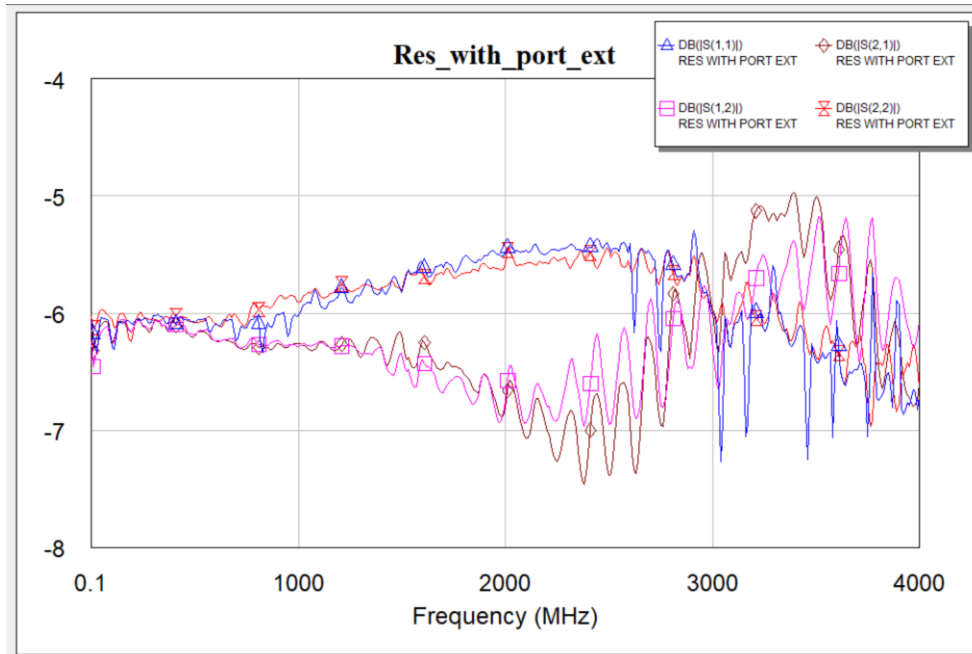
- **S-parameters of the Capacitor WITH auto-port extension**



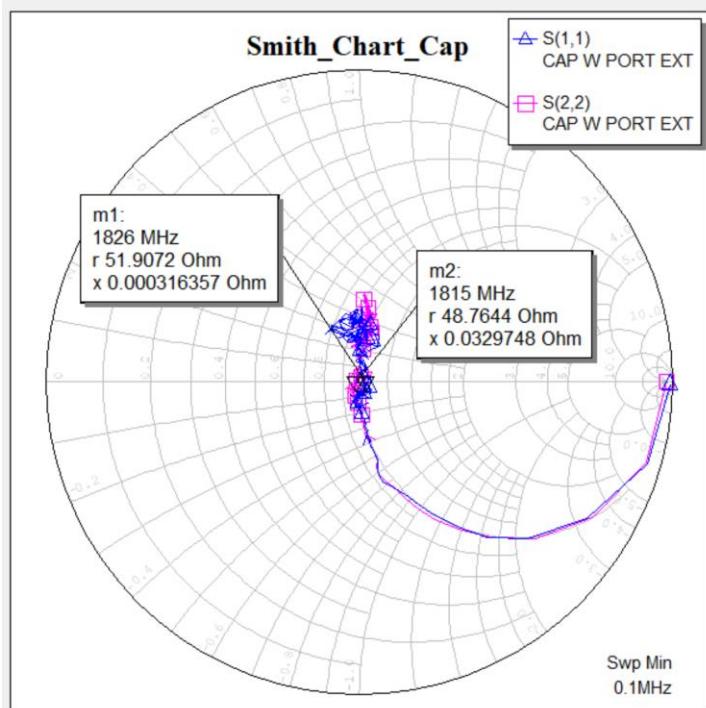
- **S-parameters of the Resistor WITHOUT auto-port extension**



- S-parameters of the Resistor WITH auto-port extension

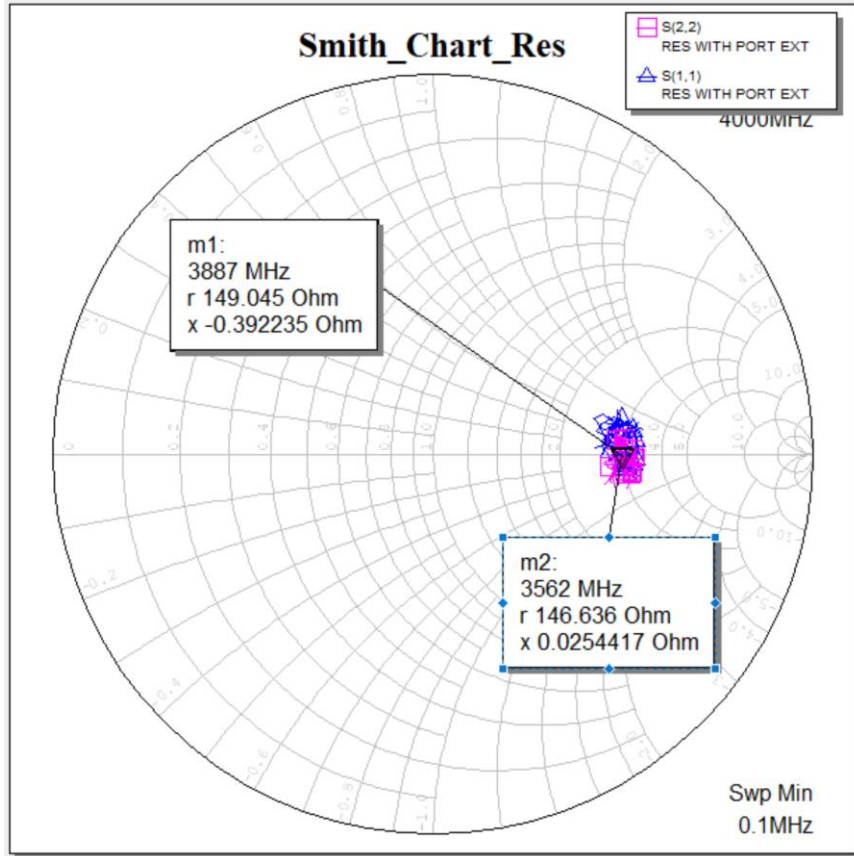


- Smith chart (S11 & S22) [put a marker at the resonant frequency of the capacitor]



Resonant frequency from S_{11} = 1826 MHz $Z = 51.9072 + j0.000316$
 Resonant frequency from S_{22} = 1815 MHz $Z = 48.7644 + j0.0329$

- Smith chart (S11 & S22) [put a marker at the resonant frequency of the resistor]



The response of resistor over the entire frequency range (0.1 – 4000 MHz) is close to the real axis which is high desirable and close to ideal

Resonant frequency from S_{11} = 3887 MHz $Z = 149.045 - j0.39$

Resonant frequency from S_{22} = 3562 MHz $Z = 146.636 + j0.025$

5. Modelling the components as lumped elements

a) For Capacitor:

Resonant frequency from S_{11} = 1826 MHz $Z = 51.9072 + j0.000316 \Omega$

Resonant frequency from S_{22} = 1815 MHz $Z = 48.7644 + j0.0329 \Omega$

Now at any arbitrary frequency say $f = 100$ MHz: $Z = 46.6 - j33.67 \Omega$

So,
$$X_c = \frac{1}{2 \times \pi \times f_c \times C}$$

Therefore,
$$C = \frac{1}{2 \times \pi \times f_c \times X_c} = \frac{1}{2 \times \pi \times 100 \times 10^6 \times 33.67} = 47.26 \text{ pF}$$

At resonant frequency using S_{11} = 1826 MHz

$$f_o = \frac{1}{2 * \pi * \sqrt{LC}}$$

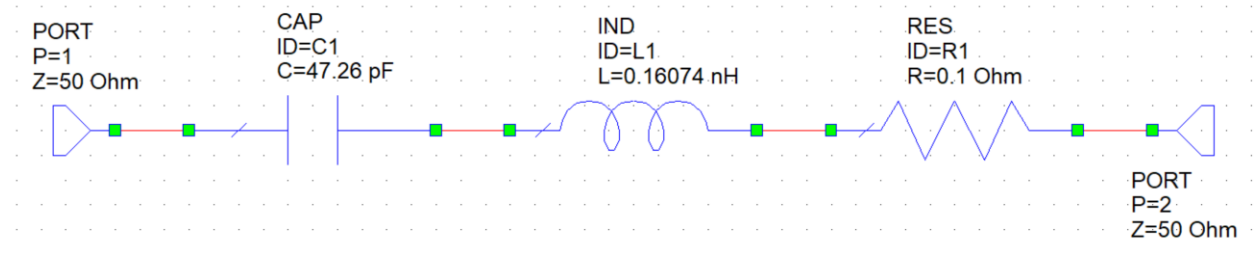
$$\sqrt{LC} = \frac{1}{2 * \pi * f_o}$$

$$\sqrt{L} = \frac{1}{2 * \pi * 1.826 * 10^9 * \sqrt{47.26 * 10^{-12}}}$$

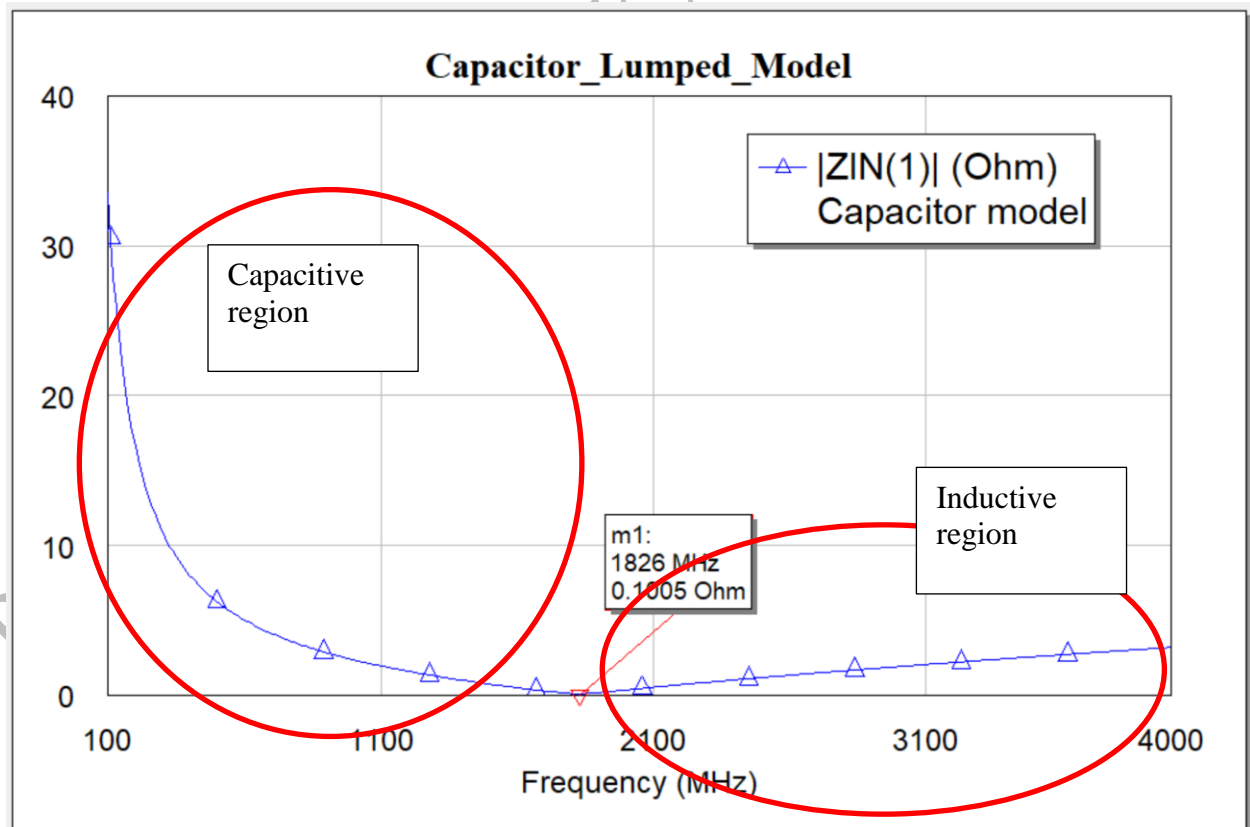
Therefore: L = 160.74 pH

Choosing an arbitrary value of 0.1Ω for the equivalent series resistance

- Equivalent lumped circuit in AWR



- Plot of Z_{in} for the equivalent lumped model



b) For Resistor:

Resonant frequency from $S_{11} = 3887$ MHz $Z = 149.045 - j0.39$
 Resonant frequency from $S_{22} = 3562$ MHz $Z = 146.636 + j0.025$

Now at any arbitrary frequency say $f = 500$ MHz: $Z = 147.533 - j12.018 \Omega$, the resistance is 147.533Ω . This observed value is in series with a 50Ω , the $R' = 147.533 - 50 = 97.533 \Omega$. The calculated value is nearly equal to the mounted resistor value, 100Ω .

So,
$$X_c = \frac{1}{2 \times \pi \times f_c \times C}$$

Therefore,
$$C = \frac{1}{2 \times \pi \times f_c \times X_c} = \frac{1}{2 \times \pi \times 500 \times 10^6 \times 12.018} = 26.48 \text{ pF}$$

At resonant frequency using $S_{22} = 3562$ MHz

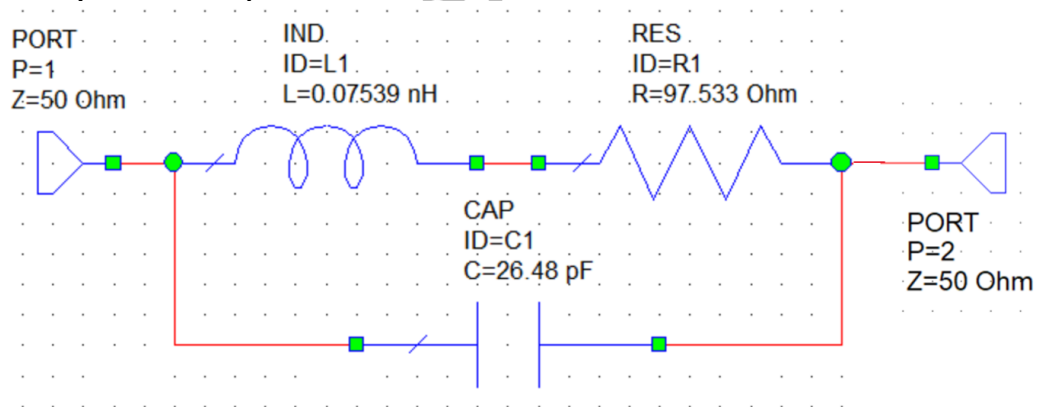
$$f_o = \frac{1}{2 * \pi * \sqrt{LC}}$$

$$\sqrt{LC} = \frac{1}{2 * \pi * f_o}$$

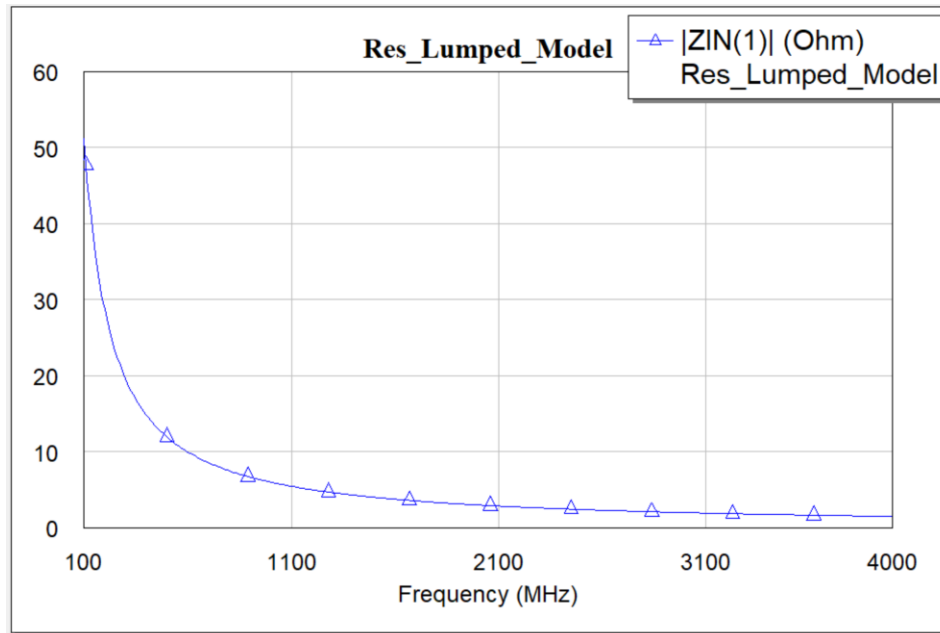
$$\sqrt{L} = \frac{1}{2 * \pi * 3.562 * 10^9 * \sqrt{26.48 * 10^{-12}}}$$

Therefore: $L = 75.39$ pH

- Equivalent lumped circuit in AWR



- Plot of Z_{in} for the equivalent lumped model



Analysis:

- After examining your measured capacitor data, over what frequency range do you feel the capacitor should be used if you want it to behave as:
 - an RF capacitor for impedance matching?
 - The reactive nature of the capacitor is minimum at its resonant frequency. Accordingly, the capacitor can be used for impedance matching around 1.826GHz.
 - an RF capacitor for DC blocking or for using as a bypass capacitor in a DC bias circuit?
 - The capacitive region is below the resonant frequency of $f = 1.826\text{GHz}$. The capacitor can be used to block DC up to 1.826 GHz. Above this it behaves like an inductor and cannot be used to block DC.
- From your microstrip transmission line measurements what can be determined about the effective dielectric constant of the circuit board used? (Assume each SMA launcher is $\sim 20\text{ps}$ of time delay in your measurement.)
- From the measurements the average time delay is 165.23 ps and the average distance is 49.027 mm

From the layout of the board,

$$V_p = \frac{\text{distance}}{(2 \times \text{measured time delay}) - \text{time delay of the 2 SMA launchers}}$$

$$= \frac{49.027 \text{ mm}}{((2 \times 165.25) - 40) \text{ ps}} = 168.18 \times 10^6 \text{ m/s}$$

$$\epsilon_{\text{eff}} = \left(\frac{c}{v_p}\right)^2$$

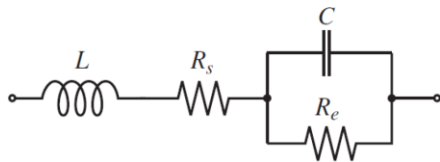
$$\therefore \epsilon_{\text{eff}} = (3 \times 10^8 \div 168.10 \times 10^6)^2$$

$$\therefore \epsilon_{\text{eff}} = 3.179$$

3. Explain your reasons for the chosen models and discuss how the models can be improved to predict the component behavior over the entire measured frequency range.

- The capacitor model:

The capacitor has dielectric sandwiched between 2 plates. The leads of the capacitor essentially are inductive by nature and also have a finite resistance. Hence the capacitor equivalent model is chosen as a series RLC circuit with appropriate values. The capacitor model can be further improved by considering the imperfections in the dielectric.



L = Lead inductance

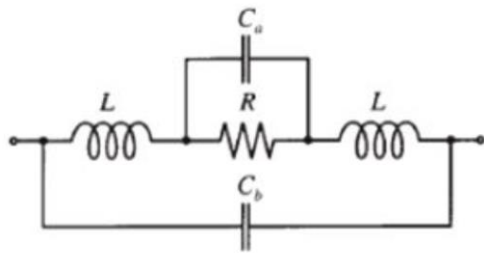
R_s = AC resistance of leads

C = Capacitance

R_e = Dielectric loss resistance

- The Resistor model:

The leads of the resistor impart an inductance and the resistive compound essentially acts as a dielectric which can be modelled by a capacitor in parallel with the series R and L. A more accurate representation is as follows:



Source: <http://www.ques10.com>

4. What is the measured Q of the (series) capacitor?

- $Q = \frac{1}{\omega RC} = \frac{1}{2\pi \times (1.826 \times 10^9) \times 0.1 \times (47.26 \times 10^{-12})} = 18.44$

Summary:

The capacitor behaves as a capacitor below its resonant frequency. For $f > f_0$ it shows inductive properties. Proper choice of capacitor is extremely essential for the given frequency and purpose. A resistor at high frequency exhibits reactance due to the presence of minute L and C which become prominent at high frequencies.

Conclusion:

The high frequency models of resistor and capacitor have been studied to decomposed to their lumped element equivalent. The usable frequency range for the component were also studied.